

S-8215A Series

BATTERY PROTECTION IC FOR 3-SERIAL TO 5-SERIAL CELL PACK (SECONDARY PROTECTION)

www.sii-ic.com

© SII Semiconductor Corporation, 2010-2016

Rev.2.3 02

The S-8215A Series is used for secondary protection of lithium-ion rechargeable batteries, and incorporates high-accuracy voltage detection circuits and delay circuits.

Short-circuiting between cells makes it possible for serial connection of three cells to five cells.

■ Features

· High-accuracy voltage detection circuit for each cell

Overcharge detection voltage n (n = 1 to 5)

3.60 V to 4.70 V (50 mV step)

Accuracy ± 25 mV (Ta = ± 25 °C)

Accuracy $\pm 30 \text{ mV}$ (Ta = -5°C to $+55^{\circ}\text{C}$)

Overcharge hysteresis voltage n (n = 1 to 5)

0.0 mV to -550 mV (50 mV step)

• Delay times for overcharge detection can be set by an internal circuit only (External capacitors are unnecessary).

Output form is selectable: CMOS output, Nch open-drain output, Pch open-drain output

• Output logic is selectable: Active "H", active "L"

High-withstand voltage: Absolute maximum rating 28 V

• Wide operation voltage range: 3.6 V to 26 V

• Wide operation temperature range: Ta = -40°C to +85°C

• Low current consumption

At V_{CUn} – 1.0 V for each cell: 3.0 μ A max. (Ta = +25°C) At 2.3 V for each cell: 1.7 μ A max. (Ta = +25°C)

• Lead-free (Sn 100%), halogen-free

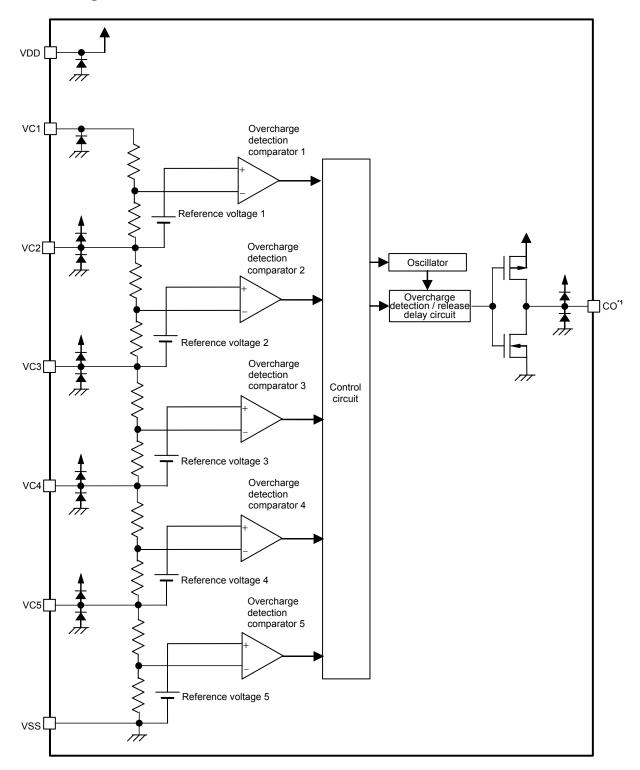
■ Application

• Lithium-ion rechargeable battery pack (for secondary protection)

■ Packages

- TMSOP-8
- SNT-8A

■ Block Diagram



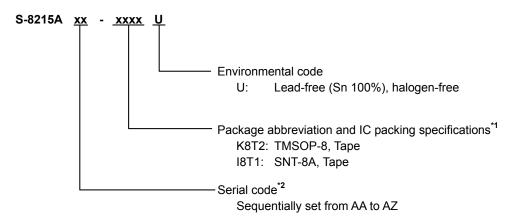
*1. The CO pin is connected only to Nch transistor in the case of Nch open-drain output. The CO pin is connected only to Pch transistor in the case of Pch open-drain output.

Remark The diodes in the figure are parasitic diodes.

Figure 1

■ Product Name Structure

1. Product name



- *1. Refer to the tape drawing.
- *2. Refer to "3. Product name list".

2. Packages

Table 1 Package Drawing Codes

Package Name Dimension		Tape	Reel	Land	
TMSOP-8	FM008-A-P-SD	FM008-A-C-SD	FM008-A-R-SD	_	
SNT-8A	PH008-A-P-SD	PH008-A-C-SD	PH008-A-R-SD	PH008-A-L-SD	

3. Product name list

3.1 TMSOP-8

Table 2

Product Name	Overcharge Detection Voltage [V _{CU}]	Overcharge Hysteresis Voltage [V _{HC}]	Overcharge Detection Delay Time [tcu]	Output Form	Output Logic
S-8215AAA-K8T2U	4.300 V	-0.300 V	4.0 s	CMOS output	Active "H"
S-8215AAB-K8T2U	4.275 V	-0.050 V	2.0 s	Nch open-drain output	Active "L"
S-8215AAC-K8T2U	4.150 V	−0.250 V	1.0 s	CMOS output	Active "H"
S-8215AAD-K8T2U	4.350 V	−0.250 V	2.0 s	CMOS output	Active "H"
S-8215AAE-K8T2U	4.325 V	-0.050 V	1.0 s	Nch open-drain output	Active "L"
S-8215AAF-K8T2U	4.220 V	-0.100 V	1.0 s	CMOS output	Active "H"
S-8215AAH-K8T2U	4.325 V	-0.300 V	1.0 s	Nch open-drain output	Active "L"
S-8215AAI-K8T2U	4.250 V	−0.250 V	1.0 s	CMOS output	Active "H"
S-8215AAJ-K8T2U	4.400 V	-0.100 V	2.0 s	CMOS output	Active "H"
S-8215AAK-K8T2U	4.150 V	-0.050 V	2.0 s	Nch open-drain output	Active "L"
S-8215AAL-K8T2U	4.150 V	-0.500 V	2.0 s	Nch open-drain output	Active "L"
S-8215AAM-K8T2U	4.150 V	-0.050 V	2.0 s	CMOS output	Active "L"
S-8215AAN-K8T2U	4.150 V	−0.500 V	2.0 s	CMOS output	Active "L"
S-8215AAO-K8T2U	4.350 V	−0.250 V	4.0 s	CMOS output	Active "H"
S-8215AAP-K8T2U	4.275 V	−0.500 V	1.0 s	CMOS output	Active "H"
S-8215AAQ-K8T2U	4.275 V	−0.050 V	1.0 s	CMOS output	Active "H"

Remark Please contact our sales office for the products with detection voltage value other than those specified above.

3. 2 SNT-8A

Table 3

Product Name	Overcharge Detection Voltage [Vcu]	Overcharge Hysteresis Voltage [V _{HC}]	Overcharge Detection Delay Time [tcu]	Output Form	Output Logic
S-8215AAA-I8T1U	4.300 V	-0.300 V	4.0 s	CMOS output	Active "H"
S-8215AAG-I8T1U	4.220 V	−0.050 V	1.0 s	CMOS output	Active "H"

Remark Please contact our sales office for the products with detection voltage value other than those specified above.

■ Pin Configurations

1. TMSOP-8

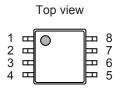


Figure 2

Table 4

Pin No.	Symbol	Description
1	VDD	Input pin for positive power supply
2	VC1	Positive voltage connection pin of battery 1
3	VC2	Negative voltage connection pin of battery 1 Positive voltage connection pin of battery 2
4	VC3	Negative voltage connection pin of battery 2 Positive voltage connection pin of battery 3
5	VC4	Negative voltage connection pin of battery 3 Positive voltage connection pin of battery 4
6	VC5	Negative voltage connection pin of battery 4 Positive voltage connection pin of battery 5
7	VSS	Input pin for negative power supply Negative voltage connection pin of battery 5
8	CO	FET gate connection pin for charge control

2. SNT-8A



Figure 3

Table 5

		1 0.010 0
Pin No.	Symbol	Description
1	VDD	Input pin for positive power supply
2	VC1	Positive voltage connection pin of battery 1
3	VC2	Negative voltage connection pin of battery 1 Positive voltage connection pin of battery 2
4	VC3	Negative voltage connection pin of battery 2 Positive voltage connection pin of battery 3
5	VC4	Negative voltage connection pin of battery 3 Positive voltage connection pin of battery 4
6	VC5	Negative voltage connection pin of battery 4 Positive voltage connection pin of battery 5
7	VSS	Input pin for negative power supply Negative voltage connection pin of battery 5
8	CO	FET gate connection pin for charge control

■ Absolute Maximum Ratings

Table 6

(Ta = $+25^{\circ}$ C unless otherwise specified)

Item		Symbol	Applied Pin	Absolute Maximum Rating	Unit
Input voltage between VDD pin and VSS pin		V_{DS}	VDD	$V_{SS}-0.3$ to $V_{SS}+28$	V
Input pin voltage	9	V _{IN}	VC1, VC2, VC3, VC4, VC5	$V_{SS} - 0.3$ to $V_{DD} + 0.3$	V
00 -:-	CMOS output product			$V_{SS} - 0.3$ to $V_{DD} + 0.3$	V
CO pin output voltage	Nch open-drain output product	V_{CO}	CO	$V_{SS}-0.3$ to $V_{SS}+28$	V
	Pch open-drain output product			$V_{DD}-28$ to $V_{DD}+0.3$	V
Power	TMSOP-8	_		650 ^{*1}	mW
dissipation	SNT-8A	PD	_	450 ^{*1}	mW
Operation ambient temperature		T _{opr}	_	−40 to +85	°C
Storage tempera	ature	T _{stg}	_	-40 to +125	°C

^{*1.} When mounted on board

[Mounted board]

(1) Board size: $114.3 \text{ mm} \times 76.2 \text{ mm} \times t1.6 \text{ mm}$ (2) Name: JEDEC STANDARD51-7

Caution The absolute maximum ratings are rated values exceeding which the product could suffer physical damage. These values must therefore not be exceeded under any conditions.

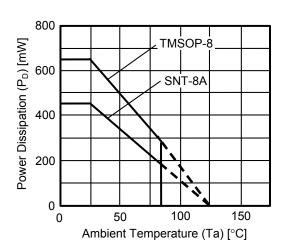


Figure 4 Power Dissipation of Package (When Mounted on Board)

■ Electrical Characteristics

Table 7

(Ta = $+25^{\circ}$ C unless otherwise specified)

	(Ta = +25°C unless otherwise specified)						
Item	Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Detection Voltage							
Overcharge detection	V	-	V _{CU} - 0.025	V _{CU}	V _{CU} + 0.025	V	1
voltage n (n = 1, 2, 3, 4, 5)	V _{CUn}	Ta = -5° C to $+55^{\circ}$ C ^{*1}	V _{CU} - 0.030	V _{CU}	V _{CU} + 0.030	V	1
		-550 mV ≤ V _{HC} ≤ -300 mV	$V_{\text{HC}} \times 0.8$	V_{HC}	$V_{\text{HC}} \times 1.2$	V	1
Overcharge hysteresis voltage n (n = 1, 2, 3, 4, 5)	V_{HCn}	-250 mV ≤ V _{HC} ≤ -100 mV	V _{HC} - 0.050	V_{HC}	V _{HC} + 0.050	V	1
voitage II (II = 1, 2, 3, 4, 5)		V _{HC} = -50 mV, 0 mV	V _{HC} - 0.025	V_{HC}	V _{HC} + 0.025	V	1
Input Voltage							
Operation voltage between VDD pin and VSS pin	V_{DSOP}	-	3.6	ı	26	V	_
Input Current							
Current consumption during operation	I _{OPE}	V1 = V2 = V3 = V4 = V5 = V _{CU} - 1.0 V	_	1.6	3.0	μΑ	3
Current consumption during overdischarge	I _{OPED}	V1 = V2 = V3 = V4 = V5 = 2.3 V	-	0.8	1.7	μΑ	3
VC1 pin current	I _{VC1}	$V1 = V2 = V3 = V4 = V5 = V_{CU} - 1.0 V$	_	0.2	0.4	μΑ	4
VCn pin current (n = 2, 3, 4, 5)	I _{VCn}	V1 = V2 = V3 = V4 = V5 = V _{CU} - 1.0 V	-0.3	0	0.3	μA	4
Output Current (CMOS Output	put Prod	luct)					•
CO pin sink current	I _{COL}	_	0.4	_	_	mA	5
CO pin source current	Ісон	_	20	_	_	μΑ	5
Output Current (Nch Open-		tput Product)					
CO pin sink current	I _{COL}	_	0.4	ı	_	mA	5
CO pin leakage current "L"	I _{COLL}	-	_	-	0.1	μΑ	5
Output Current (Pch Open-	drain Ou	tput Product)					
CO pin source current	I _{COH}	_	20	_	_	μΑ	5
CO pin leakage current "H"	I _{COLH}	-	-	-	0.1	μΑ	5
Delay Time					,		
Overcharge detection delay time	t _{CU}	-	$t_{\text{CU}}\!\times\!0.8$	t _{CU}	$t_{\text{CU}} \times 1.2$	S	1
Overcharge timer reset delay time	t _{TR}	-	6	12	20	ms	1
Transition time to test mode	t _{TST}	_	-	_	80	ms	2

^{*1.} Since products are not screened at high and low temperature, the specification for this temperature range is guaranteed by design, not tested in production.

7

■ Test Circuits

Overcharge detection voltage, overcharge hysteresis voltage (Test circuit 1)

1. 1 Overcharge detection voltage n (V_{CUn})

Set V1 = V2 = V3 = V4 = V5 = $V_{CU} - 0.05$ V. The overcharge detection voltage 1 (V_{CU1}) is the V1 voltage when the CO pin's output changes after the voltage of V1 has been gradually increased.

Overcharge detection voltage (V_{CUn}) (n = 2 to 5) can be determined in the same way as when n = 1.

1. 2 Overcharge hysteresis voltage n (V_{HCn})

Set V1 = V_{CU} + 0.05 V, V2 = V3 = V4 = V5 = 2.5 V. The overcharge hysteresis voltage 1 (V_{HC1}) is the difference between V1 voltage and V_{CU1} when the CO pin's output changes after the V1 voltage has been gradually decreased. Overcharge hysteresis voltage (V_{HCn}) (n = 2 to 5) can be determined in the same way as when n = 1.

2. Output current

(Test circuit 5)

2. 1 Output current of CMOS output product

Set SW1 and SW2 to OFF.

2. 1. 1 Active "H"

(1) CO pin source current (I_{COH})

Set SW1 to ON after setting V1 = 5.5 V, V2 to V5 = 3.0 V, V6 = 0.5 V. I1 is the CO pin source current (I_{COH}) at that time.

(2) CO pin sink current (I_{COL})

Set SW2 to ON after setting V1 to V5 = 3.5 V, V7 = 0.5 V. I2 is the CO pin sink current (I_{COL}) at that time.

2. 1. 2 Active "L"

(1) CO pin source current (I_{COH})

Set SW1 to ON after setting V1 to V5 = 3.5 V, V6 = 0.5 V. I1 is the CO pin source current (I_{COH}) at that time.

(2) CO pin sink current (I_{COL})

Set SW2 to ON after setting V1 = 5.5 V, V2 to V5 = 3.0 V, V7 = 0.5 V. I2 is the CO pin sink current (I_{COL}) at that time

2. 2 Output current of Nch open-drain output product

Set SW1 and SW2 to OFF.

2. 2. 1 Active "H"

(1) CO pin leakage current "L" (I_{COLL})

Set SW2 to ON after setting V1 = 5.5 V, V2 to V5 = 3.0 V, V7 = 17.5 V. I2 is the CO pin leakage current "L" (I_{COLL}) at that time.

(2) CO pin sink current (I_{COL})

Set V1 to V5 = 3.5 V, V7 = 0.5 V. I2 is the CO pin sink current (I_{COL}) at that time.

2. 2. 2 Active "L"

(1) CO pin leakage current "L" (I_{COLL})

Set SW2 to ON after setting V1 to V5 = 3.5 V, V7 = 17.5 V. I2 is the CO pin leakage current "L" (I_{COLL}) at that time.

(2) CO pin sink current (I_{COL})

Set V1 = 5.5 V, V2 to V5 = 3.0 V, V7 = 0.5 V. I2 is the CO pin sink current (I_{COL}) at that time.

2. 3 Output current of Pch open-drain output product

Set SW1 and SW2 to OFF.

2. 3. 1 Active "H"

(1) CO pin source current (I_{COH})

Set SW1 to ON after setting V1 = 5.5 V, V2 to V5 = 3.0 V, V6 = 0.5 V. I1 is the CO pin source current (I_{COH}) at that time.

(2) CO pin leakage current "H" (Icolh)

Set V1 to V5 = 3.5 V, V6 = 17.5 V. I1 is the CO pin leakage current "H" (I_{COLH}) at that time.

2. 3. 2 Active "L"

(1) CO pin source current (I_{COH})

Set SW1 to ON after setting V1 to V5 = 3.5 V, V6 = 0.5 V. I1 is the CO pin source current (I_{COH}) at that time.

(2) CO pin leakage current "H" (Icolh)

Set V1 = 5.5 V, V2 to V5 = 3.0 V, V6 = 17.5 V. I1 is the CO pin leakage current "H" (Icolh) at that time.

Overcharge detection delay time (t_{CU}) (Test circuit 1)

Increase V1 up to 5.0 V after setting V1 = V2 = V3 = V4 = V5 = 3.5 V. The overcharge detection delay time (t_{CU}) is the time period until the CO pin output changes.

Overcharge timer reset delay time (t_{TR}) (Test circuit 1)

Increase V1 up to 5.0 V (first rise), and decrease V1 down to 3.5 V within t_{CU} after setting V1 = V2 = V3 = V4 = V5 = 3.5 V. After that, increase V1 up to 5.0 V again (second rise), and detect the time period till the CO pin output changes. When the period from when V1 has fallen to the second rise is short, CO pin output changes after t_{CU} has elapsed since the first rise. If the period is gradually made longer, CO pin output changes after t_{CU} has elapsed since the second rise. The overcharge timer reset delay time (t_{TR}) is the period from V1 fall till the second rise at that time.

5. Transition time to test mode (t_{TST}) (Test circuit 2)

Increase V6 up to 5.0 V, and decrease V6 again to 0 V after setting V1 = V2 = V3 = V4 = V5 = 3.5 V, and V6 = 0 V. When the period from when V6 was raised to when it has fallen is short, if an overcharge detection operation is performed subsequently, the delay time is t_{CU} . However, when the period from when V6 is raised to when it has fallen is gradually made longer, the delay time during the subsequent overcharge detection operation is shorter than t_{CU} . The transition time to test mode (t_{TST}) is the period from when V6 was raised to when it has fallen at that time.

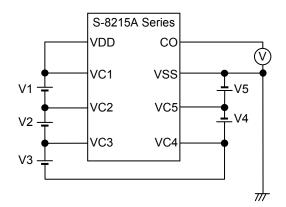


Figure 5 Test Circuit 1

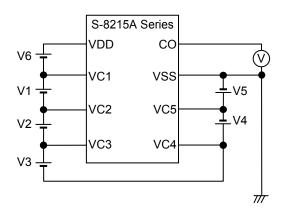


Figure 6 Test Circuit 2

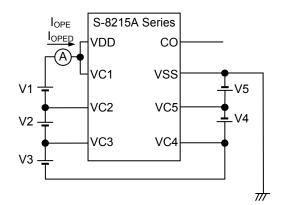


Figure 7 Test Circuit 3

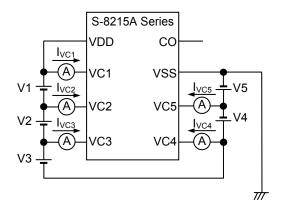


Figure 8 Test Circuit 4

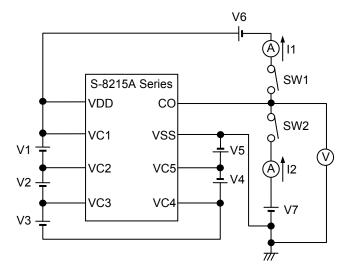


Figure 9 Test Circuit 5

Operation

Remark Refer to "■ Battery Protection IC Connection Examples".

1. Normal status

If the voltage of each of the batteries is lower than "the overcharge detection voltage n (V_{CUn}) + the overcharge hysteresis voltage n (V_{HCn})", the CO pin output changes to "L" (Active "H") or "H" (Active L"). This is called normal status.

2. Overcharge status

When the voltage of one of the batteries exceeds V_{CUn} during charging under normal conditions and the status is retained for the overcharge detection delay time (t_{CU}) or longer, the CO pin output changes. This is called overcharge status. Connecting FET to the CO pin provides charge control and a second protection.

If the voltage of each of the batteries is lower than $V_{\text{CUn}} + V_{\text{HCn}}$ and the status is retained for 2.0 ms typ. or longer, the S-8215A Series changes to normal status.

3. Overcharge timer reset function

When an overcharge release noise that forces the voltage of one of the batteries temporarily below V_{CUn} is input during t_{CU} from when V_{CUn} is exceeded to when charging is stopped, t_{CU} is continuously counted if the time the overcharge release noise persists is shorter than the overcharge timer reset delay time (t_{TR}). Under the same conditions, if the time the overcharge release noise persists is t_{TR} or longer, counting of t_{CU} is reset once. After that, when V_{CUn} has been exceeded, counting t_{CU} resumes.

4. Test mode

The overcharge detection delay time (t_{CU}) can be shortened by entering the test mode.

The test mode can be set by retaining the VDD pin voltage 5.0 V or more higher than the VC1 pin voltage for the transition time to test mode (t_{TST}) or longer. The status is retained by the internal latch and the test mode is retained even if the VDD pin voltage is decreased to the same voltage as that of the VC1 pin voltage.

After that, the latch for retaining the test mode is reset and the S-8215A Series exits from test mode under the overcharge status.

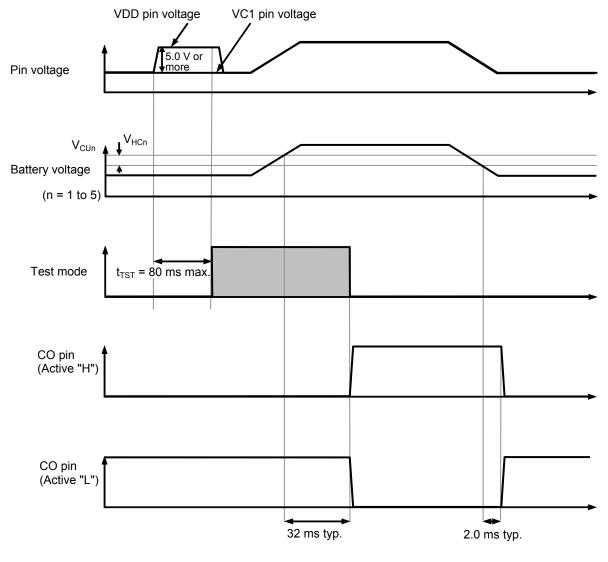


Figure 10

Caution 1. When the VDD pin voltage is decreased to lower than the UVLO voltage of 2 V typ., the S-8215A Series exits from test mode.

- 2. Set the test mode when no batteries are overcharged.
- 3. The overcharge timer reset delay time (t_{TR}) is not shortened in the test mode.

■ Timing Charts

1. Overcharge detection operation

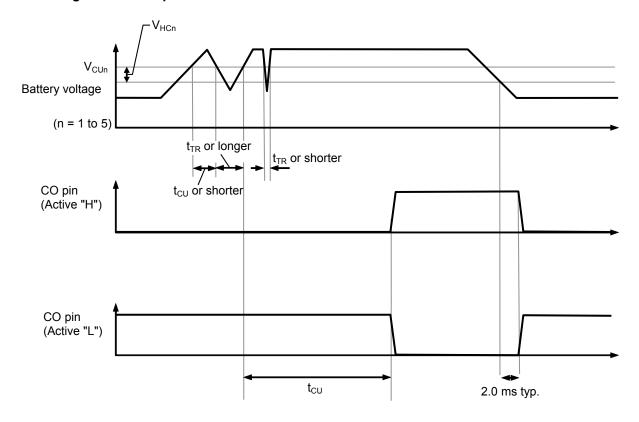


Figure 11

2. Overcharge timer reset operation

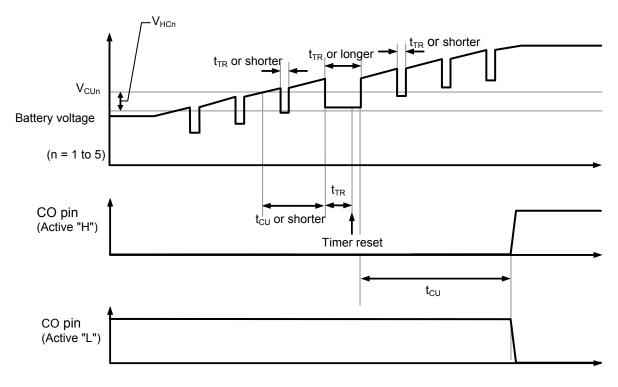


Figure 12

■ Battery Protection IC Connection Examples

1. 5-serial cell

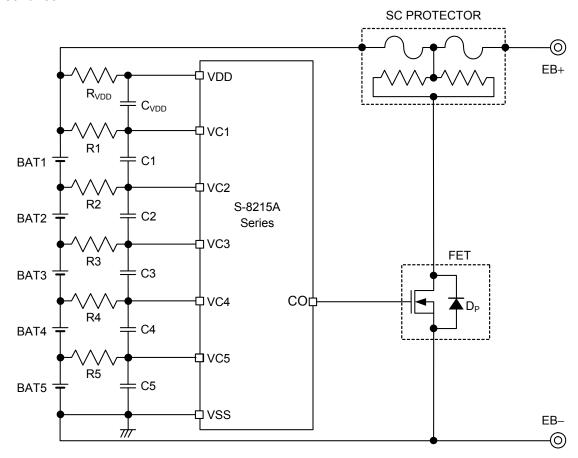


Figure 13

Table 8 Constants for External Components

No.	Part	Min.	Тур.	Max.	Unit
1	R1 to R5	0.5	1	10	kΩ
2	C1 to C5, C _{VDD}	0.01	0.1	1	μF
3	R _{VDD}	50	100	500	Ω

Caution

- 1. The above constants are subject to change without prior notice.
- 2. It has not been confirmed whether the operation is normal or not in circuits other than the above example of connection. In addition, the example of connection shown above and the constant will not guarantee successful operation. Perform thorough evaluation using the actual application to set the constant.
- 3. R1 to R5 should be the same constant. C1 to C5 and C_{VDD} should be the same constant.
- 4. Set R_{VDD} , C1 to C5, and C_{VDD} so that the condition $(R_{VDD}) \times (C1$ to C5, $C_{VDD}) \ge 5 \times 10^{-6}$ is satisfied.
- 5. Set R1 to R5, C1 to C5, and C_{VDD} so that the condition (R1 to R5) \times (C1 to C5, C_{VDD}) \geq 1 \times 10⁻⁴ is satisfied.
- Since the CO pin may become detection status transiently when the battery is being connected, connect the positive terminal of BAT1 last in order to prevent the three terminal protection fuse from cutoff.

2. 4-serial cell

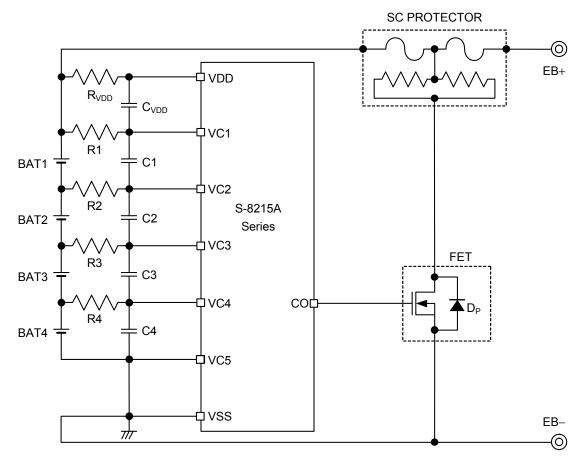


Figure 14

Table 9 Constants for External Components

No.	Part	Min.	Тур.	Max.	Unit
1	R1 to R4	0.5	1	10	kΩ
2	C1 to C4, C _{VDD}	0.01	0.1	1	μF
3	R _{VDD}	50	100	500	Ω

Caution

- 1. The above constants are subject to change without prior notice.
- It has not been confirmed whether the operation is normal or not in circuits other than the above example of connection. In addition, the example of connection shown above and the constant will not guarantee successful operation. Perform thorough evaluation using the actual application to set the constant.
- 3. R1 to R4 should be the same constant. C1 to C4 and C_{VDD} should be the same constant.
- 4. Set R_{VDD} , C1 to C4, and C_{VDD} so that the condition $(R_{VDD}) \times (C1 \text{ to C4}, C_{VDD}) \ge 5 \times 10^{-6}$ is satisfied.
- 5. Set R1 to R4, C1 to C4, and C_{VDD} so that the condition (R1 to R4) \times (C1 to C4, C_{VDD}) \geq 1 \times 10⁻⁴ is satisfied.
- 6. Since the CO pin may become detection status transiently when the battery is being connected, connect the positive terminal of BAT1 last in order to prevent the three terminal protection fuse from cutoff.

3. 3-serial cell

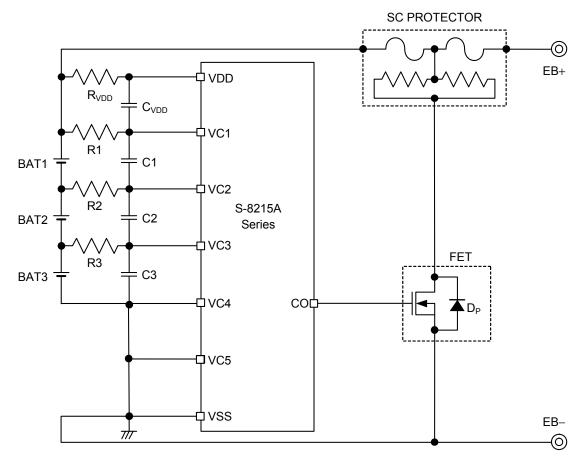


Figure 15

Table 10 Constants for External Components

No.	Part	Min.	Тур.	Max.	Unit
1	R1 to R3	0.5	1	10	kΩ
2	C1 to C3, C _{VDD}	0.01	0.1	1	μF
3	R _{VDD}	50	100	500	Ω

Caution

- 1. The above constants are subject to change without prior notice.
- It has not been confirmed whether the operation is normal or not in circuits other than the above example of connection. In addition, the example of connection shown above and the constant will not guarantee successful operation. Perform thorough evaluation using the actual application to set the constant.
- 3. R1 to R3 should be the same constant. C1 to C3 and C_{VDD} should be the same constant.
- 4. Set R_{VDD}, C1 to C3, and C_{VDD} so that the condition (R_{VDD}) \times (C1 to C3, C_{VDD}) \geq 5 \times 10⁻⁶ is satisfied.
- 5. Set R1 to R3, C1 to C3, and C_{VDD} so that the condition (R1 to R3) \times (C1 to C3, C_{VDD}) \geq 1 \times 10⁻⁴ is satisfied.
- 6. Since the CO pin may become detection status transiently when the battery is being connected, connect the positive terminal of BAT1 last in order to prevent the three terminal protection fuse from cutoff.

BATTERY PROTECTION IC FOR 3-SERIAL TO 5-SERIAL CELL PACK (SECONDARY PROTECTION) S-8215A Series Rev.2.3 02

[For SC PROTECTOR, contact]

Device Sales Dept., Advanced Process Device Division, Dexerials Corporation Gate City Osaki East Tower 8F, 1-11-2 Osaki, Shinagawa-ku, Tokyo, 141-0032 Japan TEL +81-3-5435-3946 Contact Us: http://www.dexerials.jp/en/

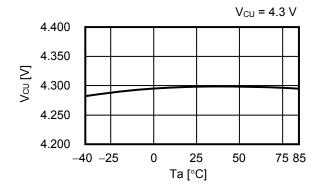
■ Precautions

- Do not connect batteries charged with V_{CUn} + V_{HCn} or higher. If the connected batteries include a battery charged with V_{CUn} + V_{HCn} or higher, the S-8215A series may become overcharge status after all pins are connected.
- In some application circuits, even if an overcharged battery is not included, the order of connecting batteries may be restricted to prevent transient output of CO detection pulses when the batteries are connected. Perform thorough evaluation with the actual application circuit.
- Before the battery connection, short-circuit the battery side pins R_{VDD} and R1, shown in the figure in "■ Battery Protection IC Connection Examples".
- The application conditions for the input voltage, output voltage, and load current should not exceed the package power dissipation.
- Do not apply to this IC an electrostatic discharge that exceeds the performance ratings of the built-in electrostatic protection circuit.
- SII Semiconductor Corporation claims no responsibility for any disputes arising out of or in connection with any infringement of patents owned by a third party by products including this IC.

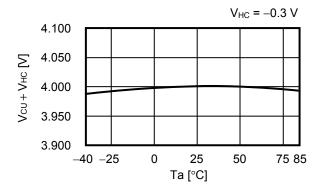
■ Characteristics (Typical Data)

1. Detection voltage

1. 1 V_{CU} vs. Ta

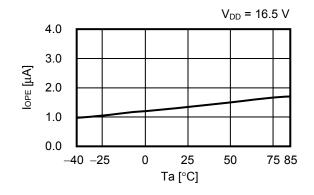


1. 2 $V_{CU} + V_{HC}$ vs. Ta

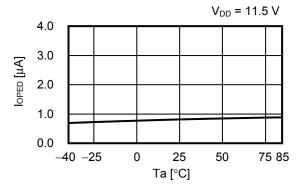


2. Current consumption

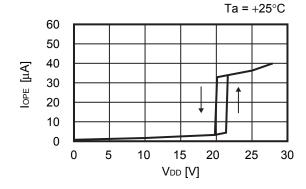
2. 1 I_{OPE} vs. Ta



2. 2 I_{OPED} vs. Ta

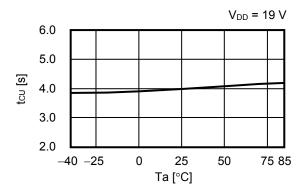


2. 3 IOPE VS. VDD



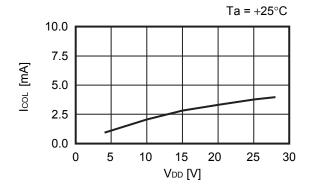
3. Delay time

3. 1 $\,t_{\text{CU}}$ vs. Ta

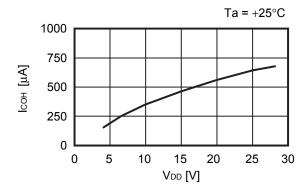


4. Output current

4. 1 I_{COL} vs. V_{DD}

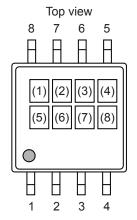


4. 2 I_{COH} vs. V_{DD}



■ Marking Specifications

1. TMSOP-8



(1): Blank

(2) to (4): Product code (Refer to Product name vs. Product code)

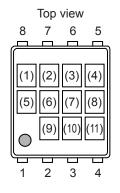
(5): Blank

(6) to (8): Lot number

Product name vs. Product code

Due divist Nove e	Pro	oduct Co	de
Product Name	(2)	(3)	(4)
S-8215AAA-K8T2U	V	6	Α
S-8215AAB-K8T2U	V	6	В
S-8215AAC-K8T2U	V	6	C
S-8215AAD-K8T2U	V	6	D
S-8215AAE-K8T2U	V	6	Е
S-8215AAF-K8T2U	V	6	F
S-8215AAH-K8T2U	V	6	Н
S-8215AAI-K8T2U	V	6	I
S-8215AAJ-K8T2U	V	6	J
S-8215AAK-K8T2U	V	6	K
S-8215AAL-K8T2U	V	6	L
S-8215AAM-K8T2U	V	6	М
S-8215AAN-K8T2U	V	6	N
S-8215AAO-K8T2U	V	6	0
S-8215AAP-K8T2U	V	6	Р
S-8215AAQ-K8T2U	V	6	Q

2. SNT-8A



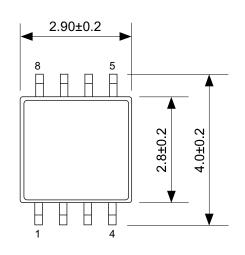
(1): Blank

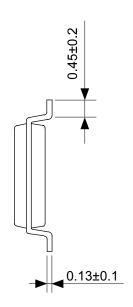
(2) to (4): Product code (Refer to **Product name vs. Product code**)

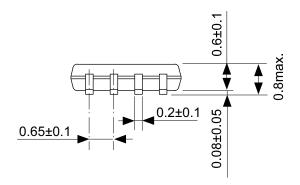
(5), (6): Blank (7) to (11): Lot number

Product name vs. Product code

Dog dog t Name a	Product Code			
Product Name	ne (2) (3	(3)	(4)	
S-8215AAA-I8T1U	V	6	Α	
S-8215AAG-I8T1U	V	6	G	

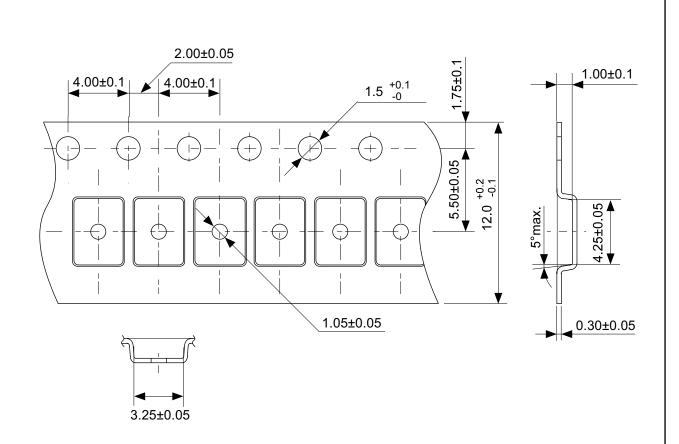


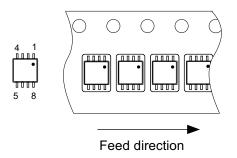




No. FM008-A-P-SD-1.2

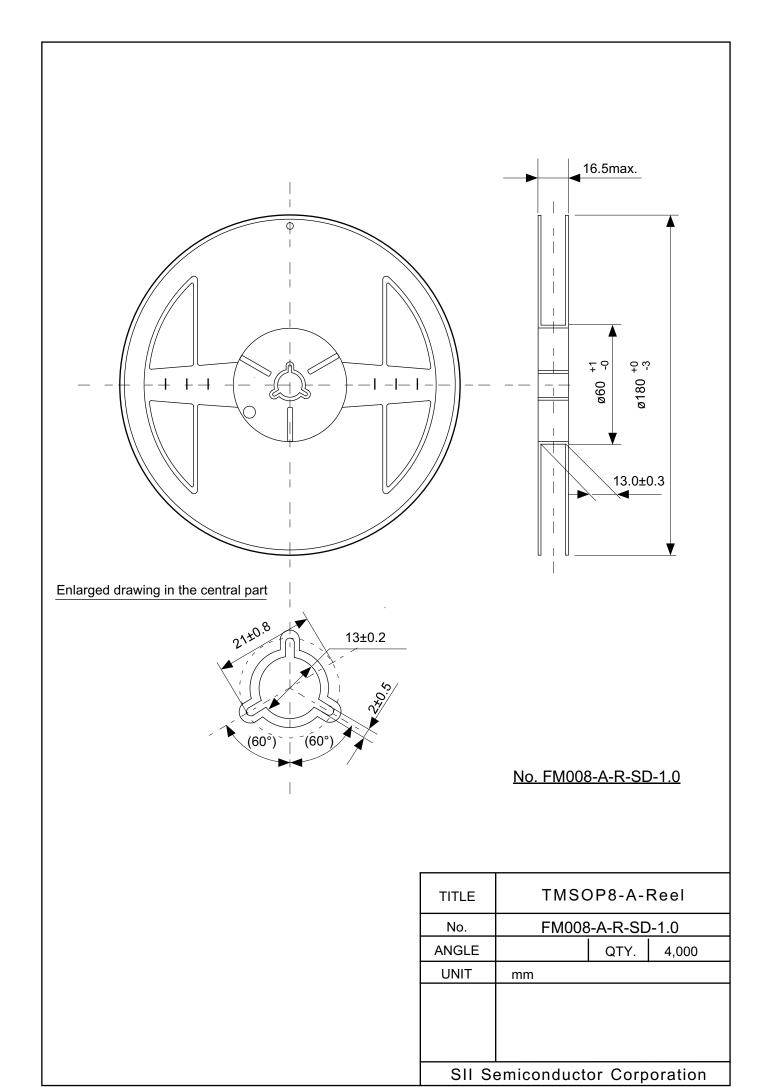
TITLE	TMSOP8-A-PKG Dimensions
No.	FM008-A-P-SD-1.2
ANGLE	\$
UNIT	mm
SII Semiconductor Corporation	

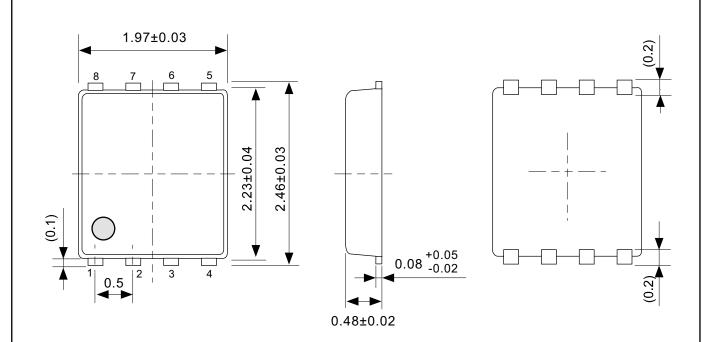


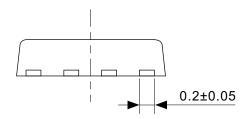


No. FM008-A-C-SD-2.0

TITLE	TMSOP8-A-Carrier Tape		
No.	FM008-A-C-SD-2.0		
ANGLE			
UNIT	mm		
SII Semiconductor Corporation			

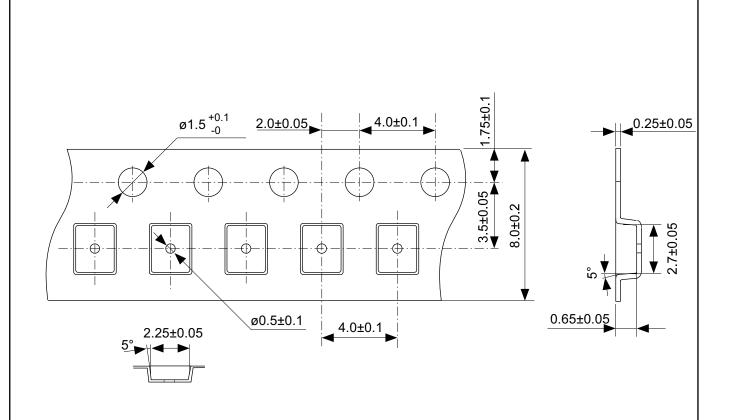


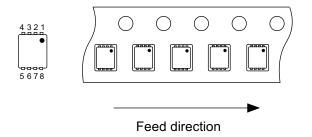




No. PH008-A-P-SD-2.1

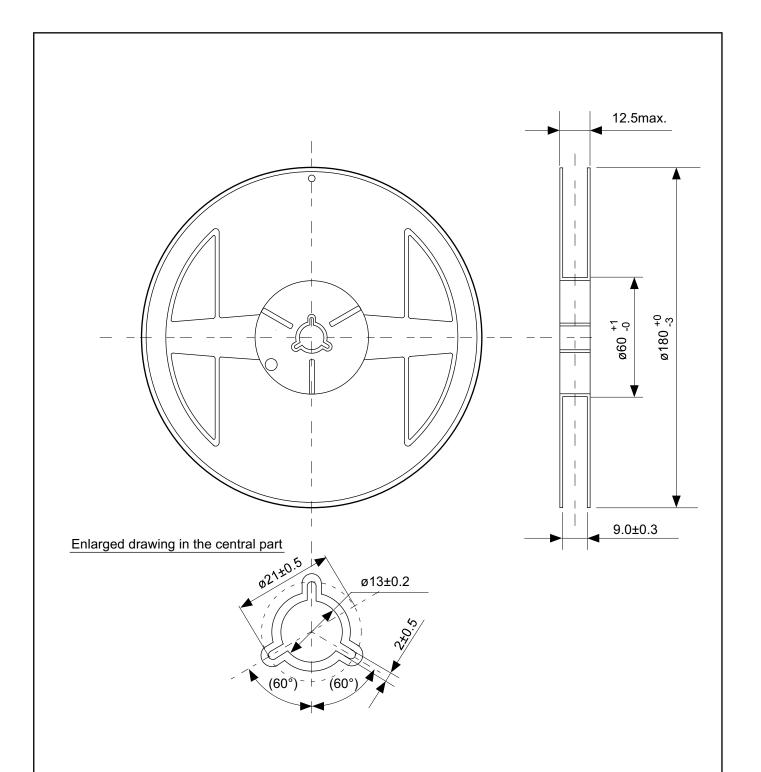
TITLE	SNT-8A-A-PKG Dimensions
No.	PH008-A-P-SD-2.1
ANGLE	\bigoplus
UNIT	mm
SII Semiconductor Corporation	





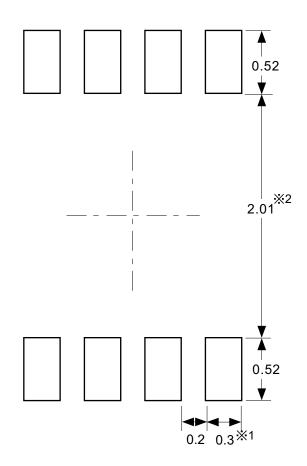
No. PH008-A-C-SD-1.0

TITLE	SNT-8A-A-Carrier Tape	
No.	PH008-A-C-SD-1.0	
ANGLE		
UNIT	mm	
SII Semiconductor Corporation		



No. PH008-A-R-SD-1.0

TITLE	SNT-8A-A-Reel		
No.	PH008-A-R-SD-1.0		
ANGLE		QTY.	5,000
UNIT	mm		
SII Semiconductor Corporation			



- ※1. ランドパターンの幅に注意してください (0.25 mm min. / 0.30 mm typ.)。 ※2. パッケージ中央にランドパターンを広げないでください (1.96 mm ~ 2.06 mm)。
- 注意 1. パッケージのモールド樹脂下にシルク印刷やハンダ印刷などしないでください。
 - 2. パッケージ下の配線上のソルダーレジストなどの厚みをランドパターン表面から0.03 mm 以下にしてください。
 - 3. マスク開口サイズと開口位置はランドパターンと合わせてください。
 - 4. 詳細は "SNTパッケージ活用の手引き"を参照してください。
- X1. Pay attention to the land pattern width (0.25 mm min. / 0.30 mm typ.).
- X2. Do not widen the land pattern to the center of the package (1.96 mm to 2.06mm).
- Caution 1. Do not do silkscreen printing and solder printing under the mold resin of the package.
 - 2. The thickness of the solder resist on the wire pattern under the package should be 0.03 mm or less from the land pattern surface.
 - 3. Match the mask aperture size and aperture position with the land pattern.
 - 4. Refer to "SNT Package User's Guide" for details.
- ※1. 请注意焊盘模式的宽度 (0.25 mm min. / 0.30 mm typ.)。
- ※2. 请勿向封装中间扩展焊盘模式 (1.96 mm~2.06 mm)。
- 注意 1. 请勿在树脂型封装的下面印刷丝网、焊锡。
 - 2. 在封装下、布线上的阻焊膜厚度 (从焊盘模式表面起) 请控制在 0.03 mm 以下。
 - 3. 钢网的开口尺寸和开口位置请与焊盘模式对齐。
 - 4. 详细内容请参阅 "SNT 封装的应用指南"。

No. PH008-A-L-SD-4.1

TITLE	SNT-8A-A -Land Recommendation	
No.	PH008-A-L-SD-4.1	
ANGLE		
UNIT	mm	
SII Semiconductor Corporation		

Disclaimers (Handling Precautions)

- 1. All the information described herein (product data, specifications, figures, tables, programs, algorithms and application circuit examples, etc.) is current as of publishing date of this document and is subject to change without notice.
- 2. The circuit examples and the usages described herein are for reference only, and do not guarantee the success of any specific mass-production design.
 - SII Semiconductor Corporation is not responsible for damages caused by the reasons other than the products or infringement of third-party intellectual property rights and any other rights due to the use of the information described herein.
- 3. SII Semiconductor Corporation is not responsible for damages caused by the incorrect information described herein.
- 4. Take care to use the products described herein within their specified ranges. Pay special attention to the absolute maximum ratings, operation voltage range and electrical characteristics, etc.
 - SII Semiconductor Corporation is not responsible for damages caused by failures and/or accidents, etc. that occur due to the use of products outside their specified ranges.
- 5. When using the products described herein, confirm their applications, and the laws and regulations of the region or country where they are used and verify suitability, safety and other factors for the intended use.
- 6. When exporting the products described herein, comply with the Foreign Exchange and Foreign Trade Act and all other export-related laws, and follow the required procedures.
- 7. The products described herein must not be used or provided (exported) for the purposes of the development of weapons of mass destruction or military use. SII Semiconductor Corporation is not responsible for any provision (export) to those whose purpose is to develop, manufacture, use or store nuclear, biological or chemical weapons, missiles, or other military use.
- 8. The products described herein are not designed to be used as part of any device or equipment that may affect the human body, human life, or assets (such as medical equipment, disaster prevention systems, security systems, combustion control systems, infrastructure control systems, vehicle equipment, traffic systems, in-vehicle equipment, aviation equipment, aerospace equipment, and nuclear-related equipment), excluding when specified for in-vehicle use or other uses. Do not use those products without the prior written permission of SII Semiconductor Corporation. Especially, the products described herein cannot be used for life support devices, devices implanted in the human body and devices that directly affect human life, etc.
 - Prior consultation with our sales office is required when considering the above uses.
 - SII Semiconductor Corporation is not responsible for damages caused by unauthorized or unspecified use of our products.
- 9. Semiconductor products may fail or malfunction with some probability.
 - The user of these products should therefore take responsibility to give thorough consideration to safety design including redundancy, fire spread prevention measures, and malfunction prevention to prevent accidents causing injury or death, fires and social damage, etc. that may ensue from the products' failure or malfunction.
 - The entire system must be sufficiently evaluated and applied on customer's own responsibility.
- 10. The products described herein are not designed to be radiation-proof. The necessary radiation measures should be taken in the product design by the customer depending on the intended use.
- 11. The products described herein do not affect human health under normal use. However, they contain chemical substances and heavy metals and should therefore not be put in the mouth. The fracture surfaces of wafers and chips may be sharp. Take care when handling these with the bare hands to prevent injuries, etc.
- 12. When disposing of the products described herein, comply with the laws and ordinances of the country or region where they are used.
- 13. The information described herein contains copyright information and know-how of SII Semiconductor Corporation. The information described herein does not convey any license under any intellectual property rights or any other rights belonging to SII Semiconductor Corporation or a third party. Reproduction or copying of the information described herein for the purpose of disclosing it to a third-party without the express permission of SII Semiconductor Corporation is strictly prohibited.
- 14. For more details on the information described herein, contact our sales office.

1.0-2016.01

